Search Notes



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Keefer, Michael E

Class	Subclass	Date	Examiner
709	203 (updated 1/9/2008)	7/10/2007	MEK
709	206 (text limited) (updated 1/9/2008)	7/11/2007	MEK

SEARCH NOTES

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EAST Search	7/11/2007	MEK
Consulted Examiner Ashok Patel	7/10/2007	MEK
EAST Search	1/9/2008	MEK
Consulted Examiner Joshua Joo	1/9/2008	MEK
Consulted Examiner Hassan Phillips	1/9/2008	MEK

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